

PRESS RELEASE

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Yokogawa releases new modules for its AQ2200 Multiple Application Test System (MATS)

Yokogawa Corporation of America is pleased to announce the continued expansion of capabilities for its modular rack mounted system AQ2200 Multiple Application Test System. Three new modules are now available. These new modules provide expanded functional performance, lower testing cost, and improved the efficiency of the AQ2200 product family.

“We’ve introduced three completely new modules with wider range, higher efficiency and better price performance in response to our customer’s testing demands.” states Paul Richardson of Yokogawa Corporation of America.

About The New Modules:

The AQ2200-215 High-Performance Optical Sensor Module. Our new optical power sensor can measure +30dBm at a very high sampling rate of 10,000 times a second and is now available for power measurement and margin testing of WDM transmission equipment. It is also designed for output power and gain testing of optical fiber amplifiers.

The AQ2200-412 1x16 Optical Switch Module. Our newest switch card developed from the demands of the customer. The new module is a fully functional 1x16 optical switch which allows greater flexibility and efficiency for testing multiple DUT. With low insertion loss and excellent reproducibility, the new 1x16 Optical Switch Module is an ideal module for companies needing to test more devices in less time.

The AQ2200-641 XFP Test Interface module. The XFP interface module is designed to incorporate the advantages of the rapidly growing XFP transceiver market. The module provides full signal control and access to the XFP transceiver with independent Data in and out, bar-Data in and out, and reference clock in. Further all XFP functions are accessible allowing the user to read, write, and control the XFP itself. While initially conceived

to provide a low cost interface for unframed and framed BER testing, the XFP module can operate independently of all other interface modules. It satisfies the measurement of the testing requirements of IEEE 802.02ae by providing such items as RX sensitivity, Center Wavelength, Spectral Width and Output power. Use of the AQ2200-641 module allows great cost savings in typical test scenarios by supporting all wavelengths available in a XFP transceiver; further, practical application testing is more affordable. Use of a Master XFP design or alternative “real-world conditioned” degraded XFP transceivers allows excellent flexibility when interfacing with the DUT. Additionally, simplified test set-ups using the AQ2200-641 allow replacement of an XFP Module Evaluation Board typically required by our customers.

About Yokogawa Corporation of America

Yokogawa Corporation of America is the North American unit of \$4 billion Yokogawa Electric Corporation, a global leader in the manufacture and supply of instrumentation, process control, and automation solutions. Headquartered in Newnan, Georgia, Yokogawa Corporation of America serves a diverse customer base with market-leading products including optical test solutions, communication test and measurement, flow meters, transmitters, controllers, recorders, data acquisition products, meters & instruments, distributed control systems, and more. Yokogawa’s AQ2200 Multiple Application Testing Systems is a generational replacement of its’ popular ANDO Electric AQ8200 MATS platform: providing greater performance and efficiency.